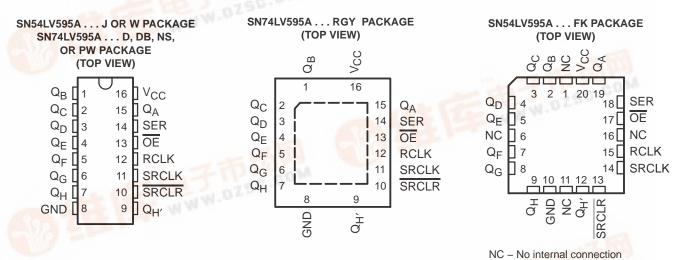
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- 2-V to 5.5-V V<sub>CC</sub> Operation
- Max tpd of 7.1 ns at 5 V
- Typical V<sub>OLP</sub> (Output Ground Bounce) <0.8 V at  $V_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot) >2.3 V at  $V_{CC} = 3.3$  V,  $T_A = 25$ °C
- **Support Mixed-Mode Voltage Operation on All Ports**
- 8-Bit Serial-In, Parallel-Out Shift

- Ioff Supports Partial-Power-Down Mode Operation
- Shift Register Has Direct Clear
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- **ESD Protection Exceeds JESD 22** 
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)



### description/ordering information

DZSC.COM The 'LV595A devices are 8-bit shift registers designed for 2-V to 5.5-V V<sub>CC</sub> operation.

### ORDERING INFORMATION

TA	PACK	AGE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
THE WW	QFN – RGY	Reel of 1000	SN74LV595ARGYR	LV595A
1-4	0010 D	Tube of 40	SN74LV595AD	11/5054
12.7	SOIC - D	Reel of 2500	SN74LV595ADR	LV595A
4000 4 0500	SOP - NS	Reel of 2000	SN74LV595ANSR	74LV595A
–40°C to 85°C	SSOP – DB Reel of 2000 SN7		SN74LV595ADBR	LV595A
		Tube of 90	SN74LV595APW	WWW.D.
	TSSOP - PW	Reel of 2000	SN74LV595APWR	LV595A
	. T. F.	Reel of 250	SN74LV595APWT	
100	CDIP – J Tube of 25 SNJ54LV595AJ		SNJ54LV595AJ	SNJ54LV595AJ
-55°C to 125°C	CFP – W	Tube of 150	SNJ54LV595AW	SNJ54LV595AW
W to	LCCC – FK Tube of 55 SNJ		SNJ54LV595AFK	SNJ54LV595AFK

Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of



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### description/ordering information (continued)

These devices contain an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. The storage register has parallel 3-state outputs. Separate clocks are provided for both the shift and storage register. The shift register has a direct overriding clear ( $\overline{SRCLR}$ ) input, serial (SER) input, and a serial output for cascading. When the output-enable ( $\overline{OE}$ ) input is high, all outputs except  $Q_{H'}$  are in the high-impedance state.

Both the shift register clock (SRCLK) and storage register clock (RCLK) are positive-edge triggered. If both clocks are connected together, the shift register always is one clock pulse ahead of the storage register.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

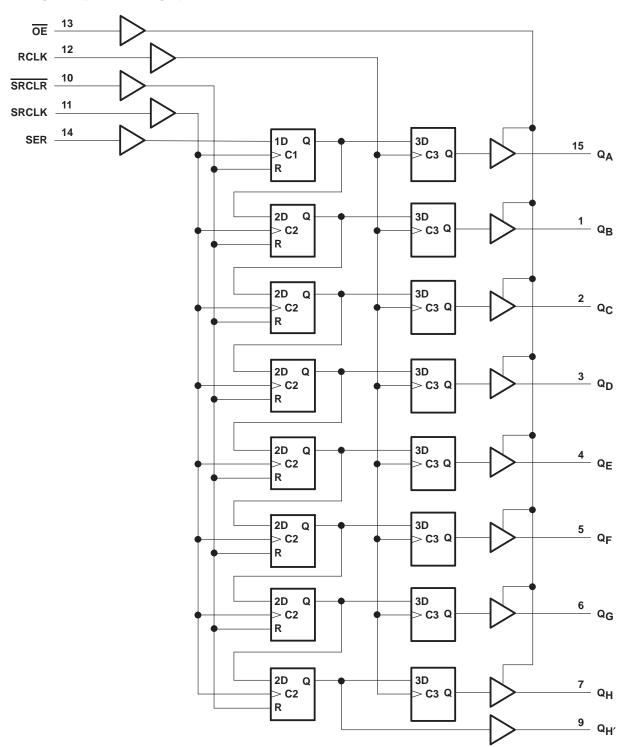
These devices are fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down.

#### **FUNCTION TABLE**

		INPUTS			FUNCTION
SER	SRCLK	SRCLR	RCLK	OE	FUNCTION
Х	Х	Х	Х	Н	Outputs Q <sub>A</sub> –Q <sub>H</sub> are disabled.
Х	Χ	X	Χ	L	Outputs Q <sub>A</sub> –Q <sub>H</sub> are enabled.
Х	Χ	L	X	Χ	Shift register is cleared.
L	1	Н	Х	Х	First stage of the shift register goes low. Other stages store the data of previous stage, respectively.
Н	1	Н	Х	Х	First stage of the shift register goes high. Other stages store the data of previous stage, respectively.
Х	Х	Х	1	Х	Shift-register data is stored in the storage register.



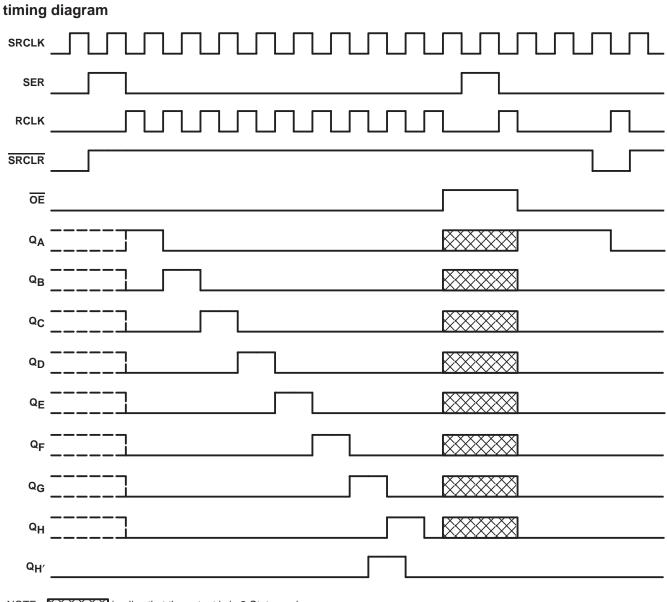
### logic diagram (positive logic)



Pin numbers shown are for the D, DB, J, NS, PW, RGY, and W packages.



### **SN54LV595A, SN74LV595A 8-BIT SHIFT REGISTERS** WITH 3-STATE OUTPUT REGISTERS SCLS414N - APRIL 1998 - REVISED APRIL 2005



NOTE: implies that the output is in 3-State mode.

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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	–0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)	
Voltage range applied to any output in the high-impedance	
or power-off state, V <sub>O</sub> (see Note 1)	0.5 V to 7 V
Output voltage range applied in the high or low state, V <sub>O</sub> (see Notes 1 and 2)	
Input clamp current, $I_{IK}$ ( $V_I < 0$ )	
Output clamp current, $I_{OK}$ ( $V_O < 0$ )	
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ )	
Continuous current through V <sub>CC</sub> or GND	
Package thermal impedance, θ <sub>JA</sub> (see Note 3): D package	
(see Note 3): DB package	82°C/W
(see Note 3): NS package	64°C/W
(see Note 3): PW package	108°C/W
(see Note 4): RGY package	
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

- 2. This value is limited to 5.5 V maximum.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.
- 4. The package thermal impedance is calculated in accordance with JESD 51-5.

### SN54LV595A, SN74LV595A **8-BIT SHIFT REGISTERS** WITH 3-STATE OUTPUT REGISTERS SCLS414N – APRIL 1998 – REVISED APRIL 2005

### recommended operating conditions (see Note 5)

			SN54L	V595A	SN74L	.V595A	
			MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage		2	5.5	2	5.5	V
		V <sub>CC</sub> = 2 V	1.5		1.5		
\ ,,	LPak Laval Carret valta es	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$		.,
VIH	High-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$	V <sub>CC</sub> ×0.7		$V_{CC} \times 0.7$		V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	V <sub>CC</sub> ×0.7		$V_{CC} \times 0.7$		
		V <sub>CC</sub> = 2 V		0.5		0.5	
\/	Low lovel input valtage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	V
VIL	Low-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	
٧ <sub>I</sub>	Input voltage		0	5.5	0	5.5	V
\/ -	Outrot values	High or low state	0	VCC	0	VCC	V
VO	Output voltage	3-state	0	5.5	0	5.5	V
		$V_{CC} = 2 V$	5	-50		-50	μΑ
١.	High lavel autout august	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	20	-2		-2	
ЮН	High-level output current	$V_{CC} = 3 V \text{ to } 3.6 V$	Q	-8		-8	mA
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		-16		-16	
		V <sub>CC</sub> = 2 V		50		50	μΑ
١.	Lava basel autout assessed	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		2		2	
lOL	Low-level output current	$V_{CC} = 3 V \text{ to } 3.6 V$		8		8	mA
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		16		16	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		200		200	
Δt/Δν	Input transition rise or fall rate	$V_{CC} = 3 V \text{ to } 3.6 V$		100		100	ns/V
		V <sub>CC</sub> = 4.5 V to 5.5 V		20		20	
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 5: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

				SN54	4LV595A		SN74	LV595A	1	
PAR	RAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
		I <sub>OH</sub> = -50 μA	2 V to 5.5 V	V <sub>CC</sub> -0.1			V <sub>CC</sub> -0.1			
		$I_{OH} = -2 \text{ mA}$	2.3 V	2			2			
.,	$Q_{H'}$	$I_{OH} = -6 \text{ mA}$		2.48			2.48			
VOH	Q <sub>A</sub> -Q <sub>H</sub>	$I_{OH} = -8 \text{ mA}$	3 V	2.48			2.48			V
	$Q_{H'}$	I <sub>OH</sub> = -12 mA	45.77	3.8			3.8			
	Q <sub>A</sub> -Q <sub>H</sub>	I <sub>OH</sub> = -16 mA	4.5 V	3.8			3.8			
		I <sub>OL</sub> = 50 μA	2 V to 5.5 V		FIN	0.1			0.1	
		$I_{OL} = 2 \text{ mA}$	2.3 V		F	0.4			0.4	
.,	$Q_{H'}$	I <sub>OL</sub> = 6 mA	0.14		2	0.44			0.44	V
VOL	$Q_A-Q_H$	I <sub>OL</sub> = 8 mA	3 V		Ć	0.44			0.44	V
	$Q_{H'}$	I <sub>OL</sub> = 12 mA	45.77	00		0.55			0.55	
	Q <sub>A</sub> -Q <sub>H</sub>	I <sub>OL</sub> = 16 mA	4.5 V	D. C.		0.55			0.55	
II		V <sub>I</sub> = 5.5 V or GND	0 to 5.5 V			±1			±1	μΑ
loz		$V_O = V_{CC}$ or GND, $Q_A - Q_H$	5.5 V			±5			±5	μΑ
Icc		$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			20			20	μΑ
l <sub>off</sub>		$V_I$ or $V_O = 0$ to 5.5 $V$	0			5			5	μΑ
Ci		V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V		3.5			3.5		pF

## timing requirements over recommended operating free-air temperature range, $V_{CC}$ = 2.5 V $\pm$ 0.2 V (unless otherwise noted) (see Figure 1)

			T <sub>A</sub> =	25°C	SN54L	/595A	SN74LV595A		LINUT
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
		SRCLK high or low	7		7.5		7.5		
t <sub>w</sub>	Pulse duration	RCLK high or low	7		7.5	FIN	7.5		ns
		SRCLR low	6		6.5		6.5		
		SER before SRCLK↑	5.5		5.5 4	Q-: 2	5.5		
١.	Outros Cara	SRCLK↑ before RCLK↑†	8		9		9		
tsu	Setup time	SRCLR low before RCLK↑	8.5		9.5		9.5		ns
		SRCLR high (inactive) before SRCLK↑	4		4		4		
th	Hold time	SER after SRCLK↑	1.5		1.5		1.5		ns

<sup>†</sup> This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.



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## timing requirements over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 1)

			T <sub>A</sub> =	25°C	SN54L	/595A	SN74L\	/595A	
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
		SRCLK high or low	5.5		5.5		5.5		
t <sub>w</sub>	Pulse duration	RCLK high or low	5.5		5.5	FW	5.5		ns
		SRCLR low	5		5	F	5		
		SER before SRCLK↑	3.5		3.5 <	Q-'	3.5		
١.	Outing the c	SRCLK↑ before RCLK↑†	8		8.5		8.5		
t <sub>su</sub>	Setup time	SRCLR low before RCLK↑	8		9		9		ns
		SRCLR high (inactive) before SRCLK↑	3		3		3		
th	Hold time	SER after SRCLK↑	1.5		1.5		1.5		ns

<sup>†</sup> This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

# timing requirements over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

			T <sub>A</sub> =	25°C	SN54L	/595A	SN74L	/595A	LINUT
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
		SRCLK high or low	5		5		5		
t <sub>w</sub>	Pulse duration	RCLK high or low	5		5	FIN	5		ns
		SRCLR low	5.2		5.2	F	5.2		
		SER before SRCLK↑	3		3 4	Ž-	3		
١.	Outros Cons	SRCLK↑ before RCLK↑†	5		5		5		
t <sub>su</sub>	Setup time	SRCLR low before RCLK↑	5		5		5		ns
		SRCLR high (inactive) before SRCLK↑	2.5		2.5		2.5		
th	Hold time	SER after SRCLK↑	2		2		2		ns

<sup>†</sup> This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.



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# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 2.5 V $\pm$ 0.2 V (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	LOAD	T	A = 25°C	;	SN54L	V595A	SN74L	/595A	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
,			C <sub>L</sub> = 15 pF	65*	80*		45*		45		N41.1-
f <sub>max</sub>			C <sub>L</sub> = 50 pF	60	70		40		40		MHz
t <sub>PLH</sub>	DOLK	0 0			8.4*	14.2*	1*	15.8*	1	15.8	
t <sub>PHL</sub>	RCLK	$Q_A-Q_H$			8.4*	14.2*	1*	15.8*	1	15.8	
t <sub>PLH</sub>	000114		]		9.4*	19.6*	1*	22.2*	1	22.2	
t <sub>PHL</sub>	SRCLK	$Q_{H'}$			9.4*	19.6*	1*	22.2*	1	22.2	
t <sub>PHL</sub>	SRCLR	Q <sub>H</sub> ′	C <sub>L</sub> = 15 pF		8.7*	14.6*	1*	16.3*	1	16.3	ns
<sup>t</sup> PZH	ŌĒ	0 0	]		8.2*	13.9*	1*	15*	1	15	
<sup>t</sup> PZL	OE	$Q_A-Q_H$	]		10.9*	18.1*	1*	20.3*	1	20.3	
<sup>t</sup> PHZ	ŌĒ	0 - 0 -			8.3*	13.7*	1*	15.6*	1	15.6	
<sup>t</sup> PLZ	OE	$Q_A-Q_H$			9.2*	15.2*	3	16.7*	1	16.7	
<sup>t</sup> PLH	RCLK	0. 0			11.2	17.2	81	19.3	1	19.3	
<sup>t</sup> PHL	RCLK	Q <sub>A</sub> –Q <sub>H</sub>	]		11.2	17.2	2 1	19.3	1	19.3	
<sup>t</sup> PLH	SRCLK	0			13.1	22.5	1	25.5	1	25.5	
<sup>t</sup> PHL	SRCLK	$Q_{H'}$	]		13.1	22.5	1	25.5	1	25.5	
<sup>t</sup> PHL	SRCLR	Q <sub>H</sub> ′	C <sub>L</sub> = 50 pF		12.4	18.8	1	21.1	1	21.1	ns
<sup>t</sup> PZH	ŌĒ	0 0	]		10.8	17	1	18.3	1	18.3	
t <sub>PZL</sub>	OE	$Q_A-Q_H$	]		13.4	21	1	23	1	23	
<sup>t</sup> PHZ	ŌĒ	0. 0	1 [		12.2	18.3	1	19.5	1	19.5	
t <sub>PLZ</sub>	OE .	Q <sub>A</sub> –Q <sub>H</sub>			14	20.9	1	22.6	1	22.6	

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

### **SN54LV595A, SN74LV595A 8-BIT SHIFT REGISTERS** WITH 3-STATE OUTPUT REGISTERS SCLS414N – APRIL 1998 – REVISED APRIL 2005

### switching characteristics over recommended operating $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 1) free-air temperature range,

	FROM	то	LOAD	T,	Δ = 25°C	;	SN54L	V595A	SN74L	/595A	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
,			C <sub>L</sub> = 15 pF	80*	120*		70*		70		N 41 1-
fmax			C <sub>L</sub> = 50 pF	55	105		50		50		MHz
<sup>t</sup> PLH	DCLK	0 - 0 -			6*	11.9*	1*	13.5*	1	13.5	
<sup>t</sup> PHL	RCLK	$Q_A-Q_H$			6*	11.9*	1*	13.5*	1	13.5	
<sup>t</sup> PLH	CDCI K	0	] [		6.6*	13*	1*	15*	1	15	
<sup>t</sup> PHL	SRCLK	$Q_{H'}$			6.6*	13*	1*	15*	1	15	
<sup>t</sup> PHL	SRCLR	$Q_{H'}$	C <sub>L</sub> = 15 pF		6.2*	12.8*	1*	13.7*	1	13.7	ns
<sup>t</sup> PZH	ŌĒ	0 . 0 .	] [		6*	11.5*	1*	13.5*	1	13.5	
<sup>t</sup> PZL	OE	Q <sub>A</sub> –Q <sub>H</sub>			7.8*	11.5*	1*	13.5*	1	13.5	
<sup>t</sup> PHZ	ŌĒ	0 - 0 -			6.1*	14.7*	1*	15.2*	1	15.2	
<sup>t</sup> PLZ	OE	$Q_A-Q_H$			6.3*	14.7*	150	15.2*	1	15.2	
<sup>t</sup> PLH	DOLK	0 . 0 .			7.9	15.4	81	17	1	17	
<sup>t</sup> PHL	RCLK	Q <sub>A</sub> –Q <sub>H</sub>			7.9	15.4	2 1	17	1	17	
t <sub>PLH</sub>	CDCI K	0	] [		9.2	16.5	1	18.5	1	18.5	
t <sub>PHL</sub>	SRCLK	Q <sub>H</sub> ′			9.2	16.5	1	18.5	1	18.5	
<sup>t</sup> PHL	SRCLR	$Q_{H'}$	C <sub>L</sub> = 50 pF		9	16.3	1	17.2	1	17.2	ns
<sup>t</sup> PZH	ŌĒ	0 0	] [		7.8	15	1	17	1	17	
tPZL	OE .	$Q_A-Q_H$			9.6	15	1	17	1	17	
<sup>t</sup> PHZ	ŌĒ	04.00			8.1	15.7	1	16.2	1	16.2	
tPLZ	OE .	Q <sub>A</sub> –Q <sub>H</sub>			9.3	15.7	1	16.2	1	16.2	

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

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# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

	FROM	то	LOAD	T,	Δ = 25°C	;	SN54L\	√595A	SN74L	/595A	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			C <sub>L</sub> = 15 pF	135*	170*		115*		115		N 41 1-
fmax			$C_{L} = 50 \text{ pF}$	120	140		95		95		MHz
<sup>t</sup> PLH	DCLK	0 - 0 -			4.3*	7.4*	1*	8.5*	1	8.5	
<sup>t</sup> PHL	RCLK	$Q_A-Q_H$			4.3*	7.4*	1*	8.5*	1	8.5	
<sup>t</sup> PLH	SDCI K	0			4.5*	8.2*	1*	9.4*	1	9.4	
<sup>t</sup> PHL	SRCLK	Q <sub>H</sub> ′			4.5*	8.2*	1*	9.4*	1	9.4	
<sup>t</sup> PHL	SRCLR	Q <sub>H</sub> ′	C <sub>L</sub> = 15 pF		4.5*	8*	1*	9.1*	1	9.1	ns
<sup>t</sup> PZH	ŌĒ	0 0			4.3*	8.6*	1*	10*	1	10	
tPZL	OE	Q <sub>A</sub> –Q <sub>H</sub>			5.4*	8.6*	1*	//10*	1	10	
<sup>t</sup> PHZ	ŌĒ	0 - 0 -			2.4*	6*	1*,	7.1*	1	7.1	
tPLZ	OE	$Q_A-Q_H$			2.7*	5.1*	1€	7.2*	1	7.2	
<sup>t</sup> PLH	RCLK	0.00			5.6	9.4	81	10.5	1	10.5	
<sup>t</sup> PHL	KCLK	Q <sub>A</sub> –Q <sub>H</sub>			5.6	9.4	2 1	10.5	1	10.5	
<sup>t</sup> PLH	SRCLK	0			6.4	10.2	1	11.4	1	11.4	
<sup>t</sup> PHL	SKULK	Q <sub>H</sub> ′			6.4	10.2	1	11.4	1	11.4	
<sup>t</sup> PHL	SRCLR	$Q_{H'}$	C <sub>L</sub> = 50 pF		6.4	10	1	11.1	1	11.1	ns
<sup>t</sup> PZH	ŌĒ	0 0			5.7	10.6	1	12	1	12	
t <sub>PZL</sub>	OE	$Q_A-Q_H$	]		6.8	10.6	1	12	1	12	
<sup>t</sup> PHZ	ŌĒ	04.00	1 🗀		3.5	10.3	1	11	1	11	
t <sub>PLZ</sub>	OE .	Q <sub>A</sub> –Q <sub>H</sub>			3.4	10.3	1	11	1	11	

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

### noise characteristics, $V_{CC} = 3.3 \text{ V}$ , $C_L = 50 \text{ pF}$ , $T_A = 25^{\circ}\text{C}$ (see Note 6)

	DADAMETED	SN	74LV595	iΑ	
	PARAMETER	MIN	TYP	MAX	UNIT
V <sub>OL(P)</sub>	Quiet output, maximum dynamic V <sub>OL</sub>		0.3		V
V <sub>OL</sub> (V)	Quiet output, minimum dynamic V <sub>OL</sub>		-0.2		V
VOH(V)	Quiet output, minimum dynamic VOH		2.8		V
VIH(D)	High-level dynamic input voltage	2.31			V
V <sub>IL(D)</sub>	Low-level dynamic input voltage			0.99	V

NOTE 6: Characteristics are for surface-mount packages only.

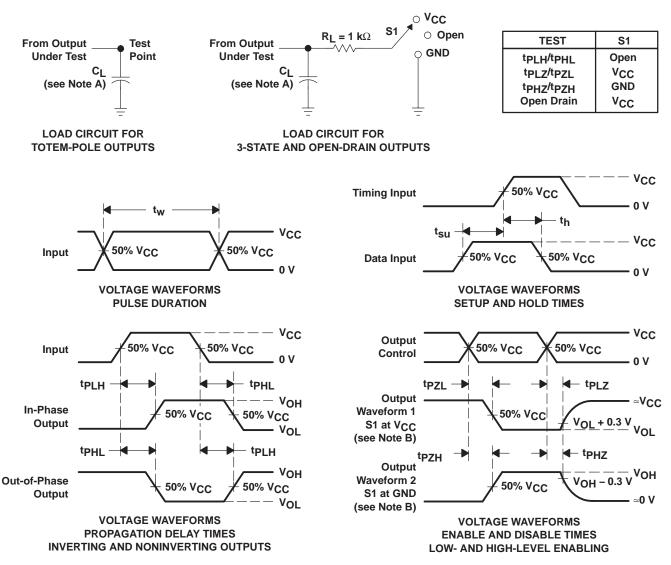
### operating characteristics, T<sub>A</sub> = 25°C

	PARAMETER		TEST CONDITIONS		VCC	TYP	UNIT
Γ	<u> </u>	Power dissipation capacitance	C <sub>L</sub> = 50 pF,	f = 10 MHz	3.3 V	111	pF
Cpd	Cpd				5 V	114	



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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_Q = 50 \Omega$ ,  $t_f \leq 3$  ns,  $t_f \leq 3$  ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G.  $t_{PHL}$  and  $t_{PLH}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms







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### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74LV595AD	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595ADBR	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595ADBRE4	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595ADE4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595ADR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595ADRE4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595ANSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595ANSRE4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595APWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595APWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595APWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595APWT	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595APWTG4	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV595ARGYR	ACTIVE	QFN	RGY	16	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
SN74LV595ARGYRG4	ACTIVE	QFN	RGY	16	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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### **PACKAGE OPTION ADDENDUM**

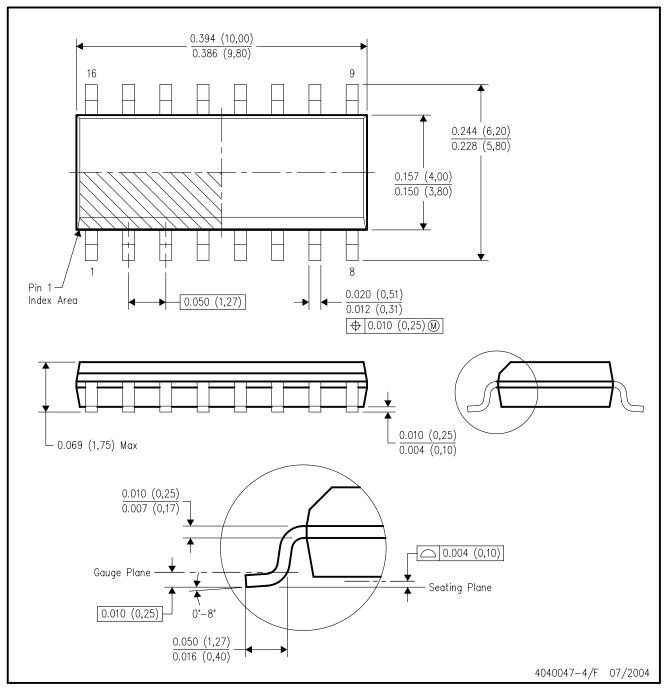
9-Aug-2005

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## D (R-PDSO-G16)

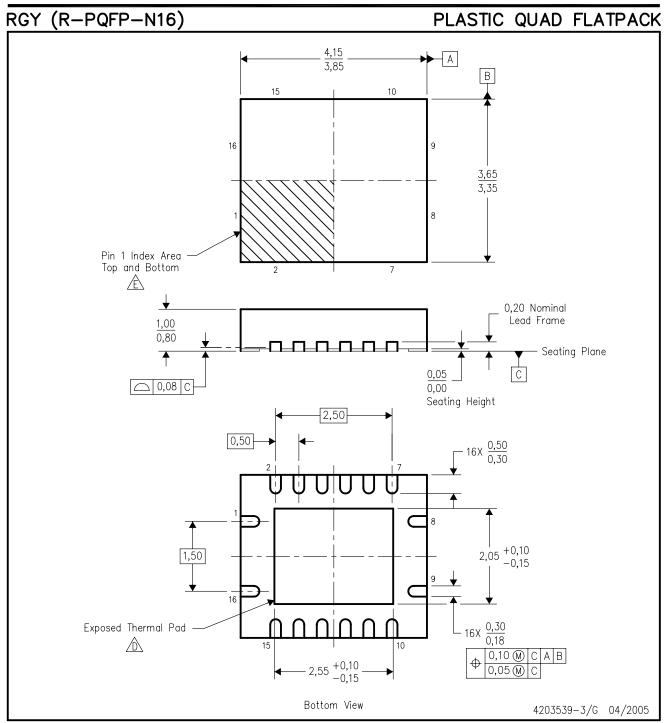
### PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- F. Package complies to JEDEC MO-241 variation BB.



### **MECHANICAL DATA**

### NS (R-PDSO-G\*\*)

### 14-PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- . All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



### DB (R-PDSO-G\*\*)

### **PLASTIC SMALL-OUTLINE**

### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



### PW (R-PDSO-G\*\*)

### 14 PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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